

**Search Notes**

Application/Control No.

10/620,428

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

CHIEN, TIEN-YUAN

Art Unit

2876

**SEARCHED**

| Class | Subclass | Date      | Examiner |
|-------|----------|-----------|----------|
| 235   | 380      | 3/15/2005 | SHL      |
| 235   | 379      | 3/15/2005 | SHL      |
| 902   | 9        | 3/15/2005 | SHL      |
| 271   | 176      | 3/15/2005 | SHL      |
| 271   | 181      | 3/15/2005 | SHL      |
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**INTERFERENCE SEARCHED**

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|                | DATE      | EXMR |
|----------------|-----------|------|
| EAST           | 3/15/2005 | SHL  |
| PCT cites      | 3/15/2005 | SHL  |
| NPL            | 3/15/2005 | SHL  |
| J. Hayes (705) | 3/15/2005 | SHL  |
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